

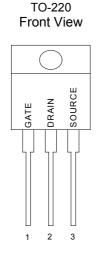
GENERAL DESCRIPTION

This Power MOSFET is designed for low voltage, high speed power switching applications such as switching regulators, converters, solenoid and relay drivers.

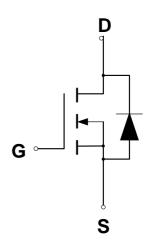
FEATURES

- Silicon Gate for Fast Switching Speeds
- ◆ Low R_{DS(on)} to Minimize On-Losses. Specified at Elevated Temperature
- ◆ Rugged SOA is Power Dissipation Limited
- Source-to-Drain Characterized for Use With Inductive Loads

PIN CONFIGURATION



SYMBOL



N-Channel MOSFET

ORDERING INFORMATION

Part Number	Package
CMT18N20N220	TO-220

ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit	
Drain to Current — Continuous		18	Α	
- Pulsed	I_{DM}	72		
Gate-to-Source Voltage — Continue		±20	V	
Non-repetitive	V_{GSM}	±40	V	
Total Power Dissipation	P_D	125	W	
Derate above 25℃		1.00	W/°C	
Operating and Storage Temperature Range	T_J, T_{STG}	-55 to 150	$^{\circ}\mathbb{C}$	
Single Pulse Drain-to-Source Avalanche Energy $-T_J = 25^{\circ}$ C		224	mJ	
$(V_{DD} = 100V, V_{GS} = 10V, I_{L} = 18A, L = 1.38mH, R_{G} = 25\Omega)$				
Thermal Resistance — Junction to Case	θ_{JC}	1.00	°CW	
 Junction to Ambient 	θ_{JA}	62.5		
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	T_L	260	$^{\circ}\mathbb{C}$	

⁽¹⁾ Pulse Width and frequency is limited by TJ(max) and thermal response



ELECTRICAL CHARACTERISTICS

Unless otherwise specified, $T_J = 25^{\circ}C$.

			CMT18N20			
Characteristic		Symbol	Min	Тур	Max	Units
Drain-Source Breakdown Voltage		V _{(BR)DSS}	200			V
$(V_{GS} = 0 \text{ V}, I_D = 250 \ \mu \text{ A})$						
Drain-Source Leakage Current		I _{DSS}				mA
$(V_{DS} = Rated V_{DSS}, V_{GS} = 0 V)$					0.025	
$(V_{DS} = 0.8Rated V_{DSS}, V_{GS} = 0 V, T_{J} = 125^{\circ}C)$					1.0	
Gate-Source Leakage Current-Ford	vard	I_{GSSF}			100	nA
$(V_{gsf} = 20 \text{ V}, V_{DS} = 0 \text{ V})$						
Gate-Source Leakage Current-Rev	erse	I _{GSSR}			100	nA
$(V_{gsr} = 20 \text{ V}, V_{DS} = 0 \text{ V})$						
Gate Threshold Voltage		$V_{GS(th)}$	2.0		4.0	V
$(V_{DS} = V_{GS}, I_{D} = 250 \mu A)$						
Static Drain-Source On-Resistance	$(V_{GS} = 10 \text{ V}, I_D = 10 \text{A}) *$	R _{DS(on)}			0.18	Ω
Drain-Source On-Voltage (V_{GS} = 10	(V)	$V_{DS(on)}$			6.0	V
$(I_D = 5.0 \text{ A})$						
Forward Transconductance (V _{DS} =	50 V, I _D = 10 A) *	g FS	6.8			mhos
Input Capacitance	$(V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$	C _{iss}			1600	pF
Output Capacitance	f = 1.0 MHz)	Coss			750	pF
Reverse Transfer Capacitance	1 - 1.0 WH 12)	C _{rss}			300	pF
Turn-On Delay Time	(V _{DD} = 30 V, I _D = 10 A.	$t_{\sf d(on)}$			30	ns
Rise Time	$V_{DD} = 30 \text{ V}, I_D = 10 \text{ A},$ $V_{GS} = 10 \text{ V},$ $R_G = 4.7\Omega)^*$	t _r			60	ns
Turn-Off Delay Time		$t_{d(off)}$			80	ns
Fall Time	NG - 4.752)	t _f			60	ns
Total Gate Charge	$(V_{DS} = 0.8Rated V_{DSS}, I_D = Rated I_D,$	Q_g		36	63	nC
Gate-Source Charge	$V_{DS} = 0.0$ Kateu V_{DSS} , $I_D = Kateu I_D$, $V_{GS} = 10 \text{ V}$)*	Q_gs		16		nC
Gate-Drain Charge	V _{GS} - 10 V)	Q_{gd}		26		nC
Internal Drain Inductance		L _D		4.5		nH
(Measured from the drain lead 0.	25" from package to center of die)					
Internal Drain Inductance		Ls		7.5		nH
(Measured from the source lead	0.25" from package to source bond pad)					
SOURCE-DRAIN DIODE CHARAC	CTERISTICS					
Forward On-Voltage(1)	(I _S = Rated I _D ,	V_{SD}			1.5	V
Forward Turn-On Time		t _{on}		**		ns
Reverse Recovery Time	$d_{ls}/d_t = 100A/\mu s)$	t _{rr}		450		ns

^{*} Pulse Test: Pulse Width $\,\leq\!300\mu\text{s},\,\text{Duty Cycle}\,\,\leq\!2\%$

^{**} Negligible, Dominated by circuit inductance



TYPICAL ELECTRICAL CHARACTERISTICS

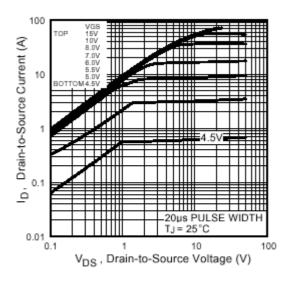


Fig 1. Typical Output Characteristics

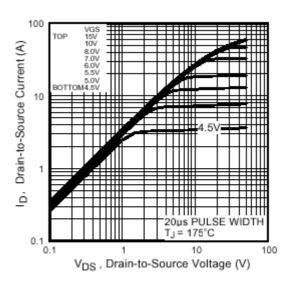


Fig 2. Typical Output Characteristics

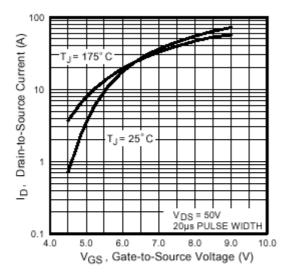


Fig 3. Typical Transfer Characteristics

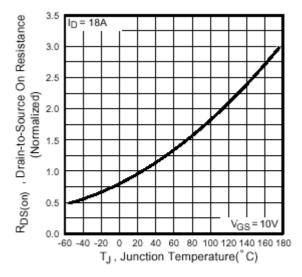


Fig 4. Normalized On-Resistance Vs. Temperature



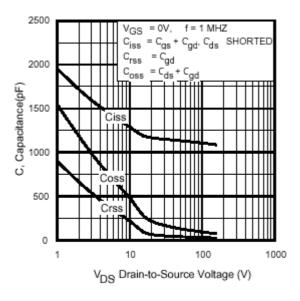


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

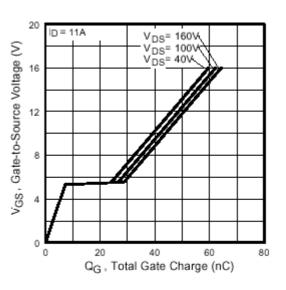


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

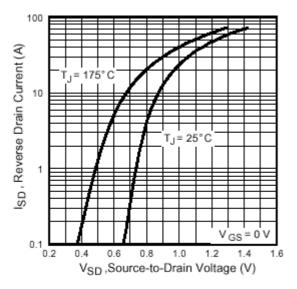


Fig 7. Typical Source-Drain Diode Forward Voltage

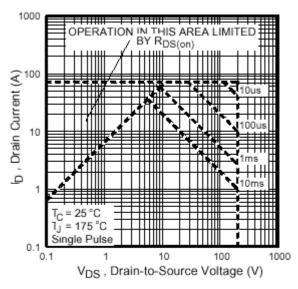


Fig 8. Maximum Safe Operating Area



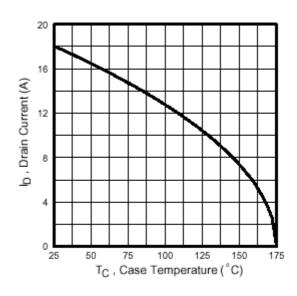


Fig 9. Maximum Drain Current Vs. Case Temperature

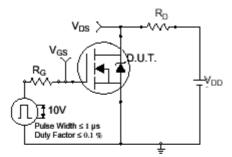


Fig 10a. Switching Time Test Circuit

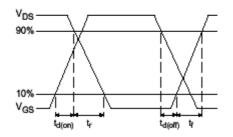


Fig 10b. Switching Time Waveforms

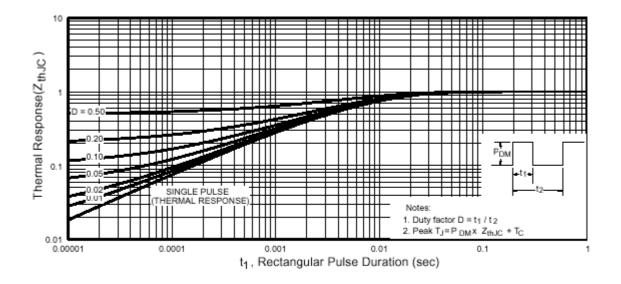


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

0.184

0.111

0.036

0.054

0.021

0.054

0.406

0.350

0.491

0.204

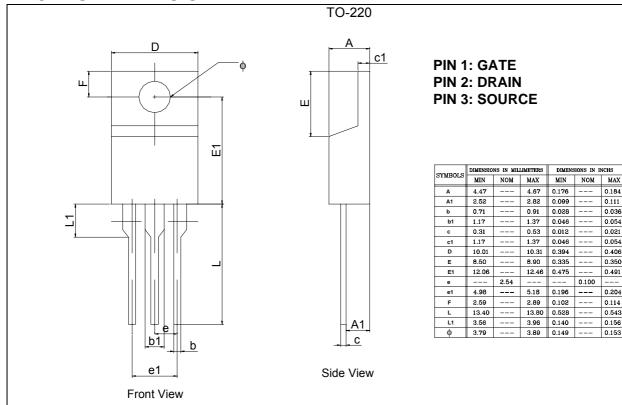
0.114

0.156

0.153



PACKAGE DIMENSION





IMPORTANT NOTICE

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